

Notice of References Cited	Application/Control No. 10/666,478	Applicant(s)/Patent Under Reexamination SCHMID ET AL.	
	Examiner Phillip Nguyen	Art Unit 2828	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,647,050 B2	11-2003	Yuen et al.	372/96
*	B	US-5,513,204 A	04-1996	Jayaraman, Vijaysekhar	372/96
*	C	US-6,553,048	04-2003	Jiang et al.	372/50.1
*	D	US-6,434,180	08-2002	Cunningham, John E	372/50.1
*	E	US-6,714,574	03-2004	Clayton et al.	372/50.1
*	F	US-2002/0146053	10-2002	Iwai, Norihiro	372/75
*	G	US-2002/0075935 A1	06-2002	Clayton, Richard D.	372/75
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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